

IRFM9140 JANTX2N7236 JANTXV2N7236 JANS2N7236

POWER MOSFET THRU-HOLE (TO-254AA)

100V, P-CHANNEL REF: MIL-PRF-19500/595 HEXFET MOSFET TECHNOLOGY

Product Summary

Part Number	R _{DS(on)}	Ι _D
IRFM9140	0.20Ω	-18A

TO-254AA

Description

HEXFET MOSFET technology is the key to IR HiRel advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high trans conductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heat sink. This improves thermal efficiency and reduces drain capacitance.

Features

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- · Electrically Isolated
- Dynamic dv/dt Rating
- Light Weight
- ESD Rating: Class 2 per MIL-STD-750, Method 1020

Absolute Maximum Ratings

	Parameter		Units
I _D @ V _{GS} = -10V, T _C = 25°C	Continuous Drain Current	-18	
I _D @ V _{GS} = -10V, T _C = 100°C	Continuous Drain Current	-11	Α
I _{DM}	Pulsed Drain Current ①	-72	
P _D @T _C = 25°C	Maximum Power Dissipation	125	W
	Linear Derating Factor	1.0	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy ②	500	mJ
I _{AR}	Avalanche Current ①	-18	Α
E _{AR}	Repetitive Avalanche Energy ①	12.5	mJ
dv/dt	Peak Diode Recovery dv/dt 3	-5.5	V/ns
T _J	Operating Junction and	-55 to + 150	
T _{STG}	Storage Temperature Range		°C
	Lead Temperature	300 (0.063 in. /1.6 mm from case for 10s)	
	Weight	9.3 (Typical)	g

For Footnotes refer to the page 2.



Electrical Characteristics @ T_i = 25°C (Unless Otherwise Specified)

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	-100			V	$V_{GS} = 0V, I_{D} = -1.0mA$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.087		V/°C	Reference to 25°C, I _D = -1.0mA
Ь	Static Drain-to-Source On-State			0.20	Ω	V _{GS} = -10V, I _D = -11A ④
$R_{DS(on)}$	Resistance			0.22	22	V _{GS} = -10V, I _D = -18A ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Gfs	Forward Transconductance	6.2			S	$V_{DS} = -15V, I_{D} = -11A$ ④
I _{DSS}	Zero Gate Voltage Drain Current			-25	μA	$V_{DS} = -80V, V_{GS} = 0V$
	Zero Gate Voltage Drain Gurrent			-250	μΛ	$V_{DS} = -80V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I_{GSS}	Gate-to-Source Leakage Forward			-100	nA	V _{GS} = -20V
	Gate-to-Source Leakage Reverse			100	ПА	V _{GS} = 20V
Q_G	Total Gate Charge			60		I _D = -18A
Q_GS	Gate-to-Source Charge			13	nC	V _{DS} = -50V
Q_{GD}	Gate-to-Drain ('Miller') Charge			35.2		V _{GS} = -10V
t _{d(on)}	Turn-On Delay Time			35		$V_{DD} = -50V$
tr	Rise Time			85	20	I _D = -11A
$t_{d(off)}$	Turn-Off Delay Time			85	ns	$R_G = 9.1\Omega$
t _f	Fall Time			65		V _{GS} = -10V
Ls +L _D	Total Inductance		6.8		nH	Measured from Drain lead (6mm / 0.25 in from package) to Source lead (6mm/ 0.25 in from package) with Source wire internally bonded from Source pin to Drain pad
C _{iss}	Input Capacitance		1400			V _{GS} = 0V
Coss	Output Capacitance		600		pF	$V_{DS} = -25V$
C _{rss}	Reverse Transfer Capacitance		200			f = 1.0MHz

Source-Drain Diode Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current (Body Diode)			-18	Α	
I _{SM}	Pulsed Source Current (Body Diode) ①			-72	A	
V_{SD}	Diode Forward Voltage			-5.0	V	$T_J = 25^{\circ}C, I_S = -18A, V_{GS} = 0V$
t _{rr}	Reverse Recovery Time			280	ns	$T_J = 25^{\circ}C, I_F = -18A, V_{DD} \le -50V$
Q_{rr}	Reverse Recovery Charge			3.6	μC	di/dt = 100A/μs ④
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case			1.0	
$R_{\theta CS}$	Case -to-Sink		0.21		°C/W
$R_{\theta JA}$	Junction-to-Ambient (Typical socket mount)			48	

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- \odot V_{DD} = -25V, starting T_J = 25°C, L = 3.1mH, Peak I_L = -18A, V_{GS} = -10V
- $\label{eq:local_spectrum} \mbox{ } \$
- 4 Pulse width \leq 300 µs; Duty Cycle \leq 2%.

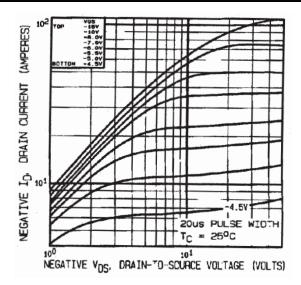


Fig 1. Typical Output Characteristics

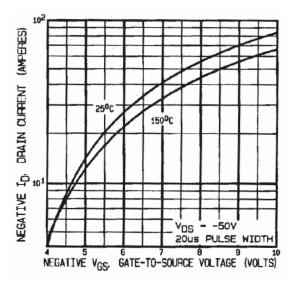


Fig 3. Typical Transfer Characteristics

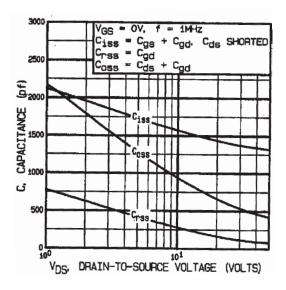


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

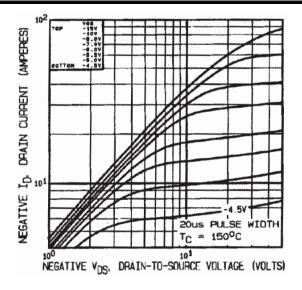


Fig 2. Typical Output Characteristics

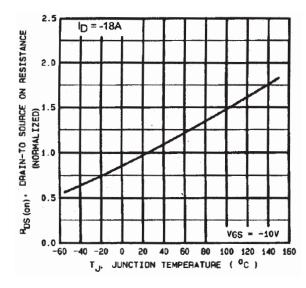


Fig 4. Normalized On-Resistance Vs. Temperature

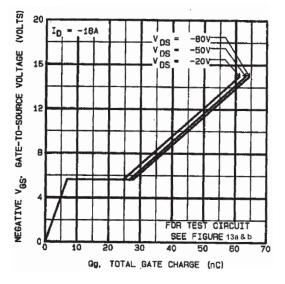


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

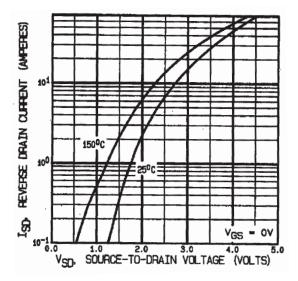


Fig 7. Typical Source-Drain Diode Forward Voltage

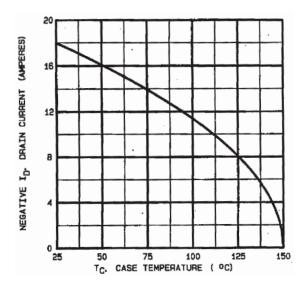


Fig 9. Maximum Drain Current Vs. Case Temperature

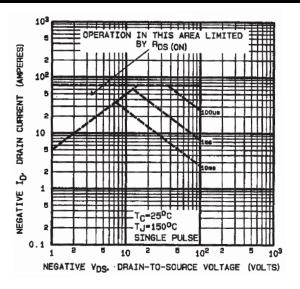


Fig 8. Maximum Safe Operating Area

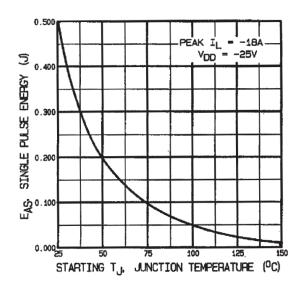


Fig 10. Maximum Avalanche Energy Vs. Drain Current

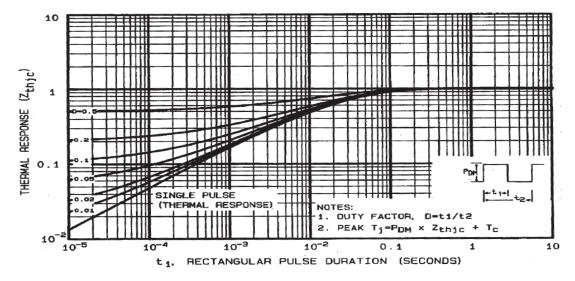


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

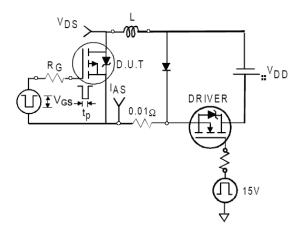


Fig 12a. Unclamped Inductive Test Circuit

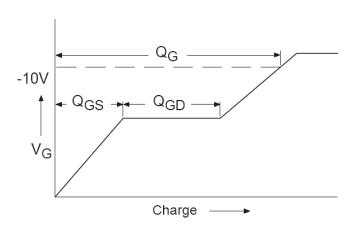


Fig 13a. Basic Gate Charge Waveform

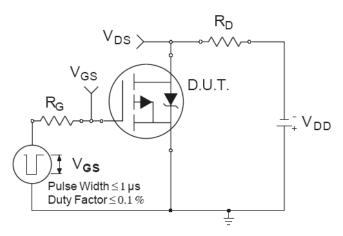


Fig 14a. Switching Time Test Circuit

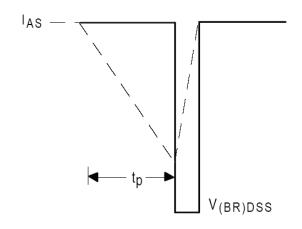


Fig 12b. Unclamped Inductive Waveforms

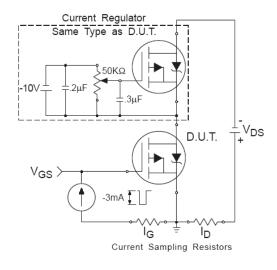


Fig 13b. Gate Charge Test Circuit

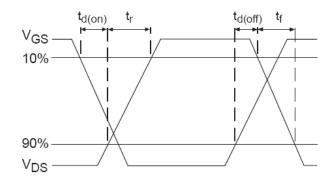
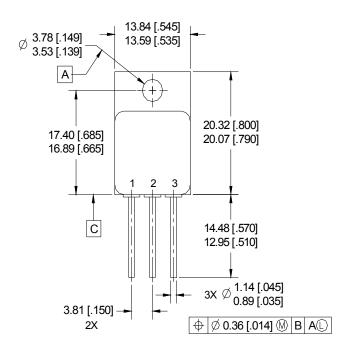
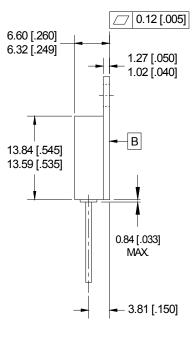


Fig 14b. Switching Time Waveforms



Case Outline and Dimensions — TO-254AA





NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. CONTROLLING DIMENSION: INCH.
- 4. CONFORMS TO JEDEC OUTLINE TO-254AA.

PIN ASSIGNMENTS

- 1 = DRAIN
- 2 = SOURCE
- 3 = GATE

BERYLLIA WARNING PER MIL-PRF-19500

Package containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.



An Infineon Technologies Company

IR HiRel Headquarters: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA Tel: (310) 252-7105
IR HiRel Leominster: 205 Crawford St., Leominster, Massachusetts 01453, USA Tel: (978) 534-5776
IR HiRel San Jose: 2520 Junction Avenue, San Jose, California 95134, USA Tel: (408) 434-5000
Data and specifications subject to change without notice.



IMPORTANT NOTICE

The information given in this document shall be in no event regarded as guarantee of conditions or characteristic. The data contained herein is a characterization of the component based on internal standards and is intended to demonstrate and provide guidance for typical part performance. It will require further evaluation, qualification and analysis to determine suitability in the application environment to confirm compliance to your system requirements.

With respect to any example hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind including without limitation warranties on non- infringement of intellectual property rights and any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's product and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of any customer's technical departments to evaluate the suitability of the product for the intended applications and the completeness of the product information given in this document with respect to applications.

For further information on the product, technology, delivery terms and conditions and prices, please contact your local sales representative or go to (www.infineon.com/hirel).

WARNING

Due to technical requirements products may contain dangerous substances. For information on the types in question, please contact your nearest Infineon Technologies office.

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for infineon manufacturer:

Other Similar products are found below:

TLE6209R BTS442E2E3062ABUMA1 EVALM113023645ATOBO1 EVALM11302TOBO1 FD1000R33HE3-K FD300R06KE3
FF1200R17KE3_B2 FF300R06KE3HOSA1 FF600R12ME4P FF600R17ME4_B11 FP25R12KT4_B11 FS150R12KE3G
FS600R07A2E3_B31 FZ1600R17HP4_B2 FZ1800R17KF4 FZ2400R17HE4_B9 FZ600R65KE3 DD261N22K DF1000R17IE4 BAT 165
E6327 BCR 141W H6327 BCR 533 E6327 BDP950H6327XTSA1 BSC093N04LSGATMA1 BSM50GB60DLC BSO080P03NS3EGXUMA
BSR802NL6327HTSA1 BSR92PH6327XTSA1 BSS806NEH6327XTSA1 BSZ086P03NS3EGATMA BTF3050TE BTM7811KAUMA1
IPD50N04S4-08 IPW60R190E6FKSA1 IRPLHID2A KIT_TC1791_SK KIT_XMC45_AE4_002 KIT_XMC4x_COM_ETH-001
EVALM10565DTOBO1 EVALM113020584DTOBO1 FF300R17KE3_S4 FF450R12ME4_B11 FF600R17ME4 T1401N42TOH
T1500N16TOF VT T1851N60TOH T901N36TOF FS300R12KE4 FS450R17KE4 FZ1500R33HE3